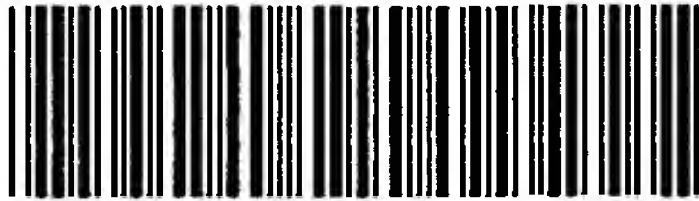


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,918	CHEN ET AL.	
	Examiner	Art Unit	
	Christopher R. Lamb	2627	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted SPE Wayne Young regarding field of search	8/17/2006	CRL
EAST Search	8/18/2006	CRL